Only Reflow Soldering Chip Monolithic Ceramic Capacitor on Interposer for General ZRB15XR61A475KE01_ (0402, X5R:EIA, 4.7uF, DC10V)

_: packaging code

muRata

Reference Sheet

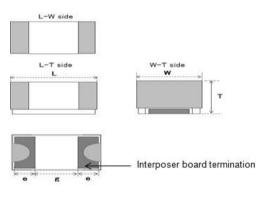
1.Scope

This product specification is applied to Chip Monolithic Ceramic Capacitor on Interposer used for General Electronic equipment. This product is applied for Only Reflow Soldering.

2.MURATA Part NO. System



3. Type & Dimensions



				(Unit:mm)
(1)-1 L	(1)-2 W	(2) T	e	g
1.0±0.15	0.5±0.15	0.65±0.15	0.1 to 0.4	0.3 min.

4.Rated value

	(3) Temperature Characteristics (Public STD Code):X5R(EIA)		(5) Nominal (0) Metho		Specifications and Test Methods
Temp. coeff or Cap. Change	Temp. Range (Ref.Temp.)	Rated Voltage	Capacitance	Tolerance	(Operating Temp. Range)
-15 to 15 %	-55 to 85 ℃ (25 ℃)	DC 10 V	4.7 uF	±10 %	-55 to 85 °C

5.Package

mark	(8) Packaging	Packaging Unit
D	∳180mm Reel PAPER W8P2	8000 pcs./Reel
J	∮330mm Reel PAPER W8P2	30000 pcs./Reel

Product specifications in this catalog are as of Jun.8,2016,and are subject to change or obsolescence without notice. Please consult the approval sheet before ordering.

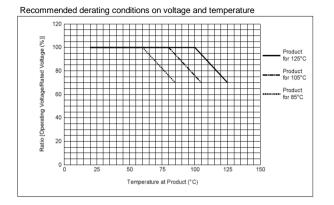
Please read rating and !Cautions first.

NIT	lite an	Prosification	Test Mathed
No 1	Item Operating	Specification R6 : -55°C to 85°C	Test Method Standard Temperature : 25°C
1	Temperature Range	R7 : -55°C to 125°C C8 : -55°C to 105°C D7 : -55°C to 125°C	Standard remperature. 23 C
2	Rated Voltage	See the previous pages.	The rated voltage is defined as the maximum voltage which may be applied continuously to the capacitor. When AC voltage is superimposed on DC voltage, V ^{P-P} or V ^{O-P} , whichever is larger, should be maintained within the rated voltage range.
3	Appearance	No defects or abnormalities.	Visual inspection.
4	Dimension	Within the specified dimensions.	Using calipers.
5	Dielectric Strength	No defects or abnormalities.	No failure should be observed when 250% of the rated voltage is applied between the terminations for 1 to 5 seconds, provided the charge/discharge current is less than 50mA.
6	Insulation Resistance	More than $50\Omega \cdot F$	The insulation resistance should be measured with a DC voltage not exceeding the rated voltage at Standard Temperature and 75%RH max. and within 1 minutes of charging, provided the charge/discharge current is less than 50mA.
7	Capacitance	Within the specified tolerance.	The capacitance / D.F. should be measured at Standard Temperature at the frequency and voltage shown in the table.
8	Dissipation Factor (D.F.)	R6,R7,C8,D7 : 0.1 max.	$\label{eq:constraint} \begin{array}{ c c c c } \hline C & = & Frequency & Voltage \\ \hline C & \leq 10 \mu F & 1 \pm 0.1 \text{ kHz} & 1.0 \pm 0.2 \text{ Vrms} \\ \hline (10\text{ V min.}) & 1 \pm 0.1 \text{ kHz} & 1.0 \pm 0.2 \text{ Vrms} \\ \hline C & \leq 10 \mu F & 1 \pm 0.1 \text{ kHz} & 0.5 \pm 0.1 \text{ Vrms} \\ \hline C & > 10 \mu F & 120 \pm 24 \text{ Hz} & 0.5 \pm 0.1 \text{ Vrms} \\ \hline C & > 10 \mu F & 120 \pm 24 \text{ Hz} & 0.5 \pm 0.1 \text{ Vrms} \\ \hline I & 7.\text{ Capacitance} \end{bmatrix} \\ \hline \text{Perform a heat treatment at 150+0/-10°C for one hour and then set for} \\ 24 \pm 2 \text{ hour at room temperature. Perform the initial measurement.} \end{array}$
9	Capacitance No bias Temperature Characteristics	R6 : Within $\pm 15\%$ (-55°C to +85°C) R7 : Within $\pm 15\%$ (-55°C to +125°C) C8 : Within $\pm 22\%$ (-55°C to +105°C) D7 : Within +22%, -33% (-55°C to +125°C)	To apply the test voltge through the Interposer board termination. The capacitance change should be measured after 5min. at each specified temp. stage. In case of applying voltage, the capacitance change should be measured after 1 more min. with applying voltage in equilibration of each temp. stage. · Measurement Voltage ZRB15X R6 1A 475 only : 0.10±0.03Vrms Test Conditions
			Step Temperature(°C) Applying voltage(V) 1 25+/-2(for R6,R7,C8,D7) voltage(V) 2 -55+/-3(for R6,R7,C8,D7) voltage(V) 3 25+/-2(for R6,R7,C8,D7) No bias 4 125±3(for R6) 105±3(for C8) voltage(V)
10	Adhesive Strength of Termination	No removal of the terminations or other defect should occur.	To apply the test voltge through the Interposer board termination. Initial measurement Perform a heat treatment at 150+0/-10°C for one hour and then set at room temperature for 24±2 hours. Perform the initial measurement. Solder the capacitor on the test jig (glass epoxy board) shown in Fig.3 using an eutectic solder. Then apply 5N force in parallel with the test jig for 10+/-1sec. The soldering should be done either with an iron or using the reflow method and should be conducted with care so that the soldering is uniform and free of defects such as heat shock.

SPECIFICATIONS AND TEST METHODS

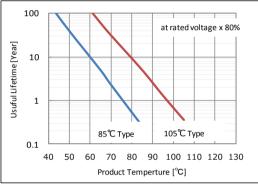
No	lt	em	Specification	Test Method
11	Vibration	Appearance	No defects or abnormalities.	Solder the capacitor on the test jig (glass epoxy board) shown in Fig.3
	Resistance	Capacitance	Within the specified tolerance.	using an eutectic solder. The capacitor should be subjected to a simple harmonic motion having
				a total amplitude of 1.5mm, the frequency being varied uniformly between
		D.F.	R6,R7,C8,D7 : 0.1 max.	the approximate limits of 10 and 55Hz.
				The frequency range, from 10 to 55Hz and return to 10Hz, should be traversed in approximately 1 minute. This motion should be applied for a period of
				2 hours in each 3 mutually perpendicular directions(total of 6 hours).
2	Deflection	Appearance	No defects or abnormalities.	Solder the capacitor on the test jig (glass epoxy board) shown in Fig.1 using an eutectic solder.
		Capacitance	Within ±10%	Then apply a force in the direction shown in Fig 2 for 5±1 sec.
		Change		The soldering should be done by the reflow method and should be conducted
				with care so that the soldering is uniform and free of defects such as heat
3	Solderability		75% of the terminations is to be soldered evenly	shock. Immerse the capacitor in a solution of ethanol (JIS-K-8101) and rosin
	of Termin	ation	and continuously.	(JIS-K-5902) (25% rosin in weight proportion)
				Preheat at 80 to 120°C for 10 to 30 seconds.
				After preheating, immerse in an eutectic solder solution for 2±0.5 seconds at 230±5°C or Sn-3.0Ag-0.5Cu solder solution for 2±0.5 seconds at 245±5°C.
4	Resistance to	Appearance	No defects or abnormalities.	Test Conditions : Reflow method
	Soldering Heat			Solder : Sn-3.0Ag-0.5 Cu solder
		Capacitance Change	R6,R7,C8,D7 : Within ±7.5%	Solder Temperature : 255°C ±10°C[Peak Temperature]
		Ghange		Heat Time of over 200°C : 120s min
		D.F.	R6,R7,C8,D7 : 0.1 max.	Exposure to room temperature : 24±2h
				Pre-heat : Following conditions
				Table1
				Temperature Time
		I.R.	More than 50Ω · F	150°C to 160°C 2 min.
		Dielectric	No defects.	Initial measurement
		Strength		Perform a heat treatment at 150+0/-10°C for one hour and then set at room
				temperature for 24±2 hours. Perform the initial measurement.
5	Temperature	Appearance	No defects or abnormalities.	Solder the capacitor on the test jig (glass epoxy board) shown in Fig.3
5	Sudden	Appearance	No defects of abhormanities.	using an eutectic solder.
	Change	Capacitance	R6,R7,C8,D7 : Within ±7.5%	Perform the five cycles according to the four heat treatments
		Change		shown in the following table. Set for 24±2 hours at room temperature, then measure.
				Ster lor 24±2 hours at room temperature, then measure.
		D.F.	R6,R7,C8,D7 : 0.1 max.	1 Min. Operating Temp.+0/-3 30±3
				2 Room Temp 2 to 3
				3 Max.Operating Temp.+3/-0 30±3
				3 Max.Operating Temp.+3/-0 30±3 4 Room Temp 2 to 3
				4 Room Temp 2 to 3
		I.R.	More than 50 Ω \cdot F	4 Room Temp 2 to 3
		I.R.	More than 50 Ω \cdot F	4 Room Temp 2 to 3 Initial measurement Perform a heat treatment at 150+0/-10°C for one hour and then let sit
		I.R. Dielectric	More than 50Ω · F No defects.	4 Room Temp 2 to 3
				4 Room Temp 2 to 3 • Initial measurement Perform a heat treatment at 150+0/-10°C for one hour and then let sit for 24±2 hours at room temperature. Perform the initial measurement. • GRM188B30J106M Measurement after test: Perform a heat treatment and then let sit for 24±2 hours at room
	High	Dielectric Strength	No defects.	4 Room Temp 2 to 3 • Initial measurement Perform a heat treatment at 150+0/-10°C for one hour and then let sit for 24±2 hours at room temperature. Perform the initial measurement. • GRM188B30J106M Measurement after test: Perform a heat treatment and then let sit for 24±2 hours at room temperature, then measure.
16	High Temperature	Dielectric		4 Room Temp 2 to 3 • Initial measurement Perform a heat treatment at 150+0/-10°C for one hour and then let sit for 24±2 hours at room temperature. Perform the initial measurement. • GRM188B30J106M Measurement after test: Perform a heat treatment and then let sit for 24±2 hours at room
6	Temperature High	Dielectric Strength Appearance Capacitance	No defects.	4 Room Temp 2 to 3 • Initial measurement Perform a heat treatment at 150+0/-10°C for one hour and then let sit for 24±2 hours at room temperature. Perform the initial measurement. • GRM188B30J106M Measurement after test: Perform a heat treatment and then let sit for 24±2 hours at room temperature, then measure. Solder the capacitor on the test jig (glass epoxy board) shown in Fig.3 using an eutectic solder. Apply the rated voltage at 40±2°C and 90 to 95% humidity for 500±12 hours.
6	Temperature High Humidity	Dielectric Strength Appearance	No defects. No defects or abnormalities.	4 Room Temp 2 to 3 • Initial measurement Perform a heat treatment at 150+0/-10°C for one hour and then let sit for 24±2 hours at room temperature. Perform the initial measurement. • GRM188B30J106M Measurement after test: Perform a heat treatment and then let sit for 24±2 hours at room temperature, then measure. Solder the capacitor on the test jig (glass epoxy board) shown in Fig.3 using an eutectic solder. Apply the rated voltage at 40±2°C and 90 to 95% humidity for 500±12 hours. The charge/discharge current is less than 50mA.
6	Temperature High	Dielectric Strength Appearance Capacitance Change	No defects. No defects or abnormalities. R6,R7,C8,D7 : Within ±12.5%	4 Room Temp 2 to 3 • Initial measurement Perform a heat treatment at 150+0/-10°C for one hour and then let sit for 24±2 hours at room temperature. Perform the initial measurement. • GRM188B30J106M Measurement after test: Perform a heat treatment and then let sit for 24±2 hours at room temperature, then measure. Solder the capacitor on the test jig (glass epoxy board) shown in Fig.3 using an eutectic solder. Apply the rated voltage at 40±2°C and 90 to 95% humidity for 500±12 hours. The charge/discharge current is less than 50mA. • Initial measurement
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6	Temperature High Humidity	Dielectric Strength Appearance Capacitance Change D.F.	No defects. No defects or abnormalities. R6,R7,C8,D7 : Within ±12.5% R6,R7,C8,D7 : 0.2max.	4 Room Temp 2 to 3 • Initial measurement Perform a heat treatment at 150+0/-10°C for one hour and then let sit for 24±2 hours at room temperature. Perform the initial measurement. • GRM188B30J106M Measurement after test: Perform a heat treatment and then let sit for 24±2 hours at room temperature. Solder the capacitor on the test jig (glass epoxy board) shown in Fig.3 using an eutectic solder. Apply the rated voltage at 40±2°C and 90 to 95% humidity for 500±12 hours. The charge/discharge current is less than 50mA. • Initial measurement Perform a heat treatment at 150+0/-10°C for one hour and then let sit for 24±2 hours at room temperature. Perform the initial measurement.
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	Temperature High Humidity (Steady)	Dielectric Strength Appearance Capacitance Change D.F.	No defects. No defects or abnormalities. R6,R7,C8,D7 : Within ±12.5% R6,R7,C8,D7 : 0.2max. More than 6Ω · F No defects or abnormalities.	4 Room Temp 2 to 3 • Initial measurement Perform a heat treatment at 150+0/-10°C for one hour and then let sit for 24±2 hours at room temperature. Perform the initial measurement. • GRM188B30J106M Measurement after test: Perform a heat treatment and then let sit for 24±2 hours at room temperature, then measure. Solder the capacitor on the test jig (glass epoxy board) shown in Fig.3 using an eutectic solder. Apply the rated voltage at 40±2°C and 90 to 95% humidity for 500±12 hours. The charge/discharge current is less than 50mA. • Initial measurement Perform a heat treatment at 150+0/-10°C for one hour and then let sit for 24±2 hours at room temperature. Perform the initial measurement. • Measurement after test Perform a heat treatment at 150+0/-10°C for one hour and then let sit for 24±2 hours at room temperature. Perform the initial measurement. • Measurement after test Perform a heat treatment at 150+0/-10°C for one hour and then let sit for 24±2 hours at room temperature. Perform the initial measurement.
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	Temperature High Humidity (Steady)	Dielectric Strength Appearance Capacitance Change D.F. I.R. Appearance	No defects. No defects or abnormalities. R6,R7,C8,D7 : Within ±12.5% R6,R7,C8,D7 : 0.2max. More than 6Ω · F No defects or abnormalities.	4 Room Temp 2 to 3 • Initial measurement Perform a heat treatment at 150+0/-10°C for one hour and then let sit for 24±2 hours at room temperature. Perform the initial measurement. • GRM188B30J106M Measurement after test: Perform a heat treatment and then let sit for 24±2 hours at room temperature. Solder the capacitor on the test jig (glass epoxy board) shown in Fig.3 using an eutectic solder. Apply the rated voltage at 40±2°C and 90 to 95% humidity for 500±12 hours. The charge/discharge current is less than 50mA. • Initial measurement Perform a heat treatment at 150+0/-10°C for one hour and then let sit for 24±2 hours at room temperature. Perform the initial measurement. • Measurement at room temperature. Perform the initial measurement. • Measurement attreatment and then let sit for 24±2 hours at room temperature. Solder the capacitor on the test jig (glass epoxy board) shown in Fig.3 using an eutectic solder. Apply 100% of the rated voltage for 1000±12 hours at the maximum operating temperature ±3°C. The charge/ discharge current is less than 50mA
	Temperature High Humidity (Steady)	Dielectric Strength Appearance Capacitance Change D.F. I.R. Appearance Capacitance	No defects. No defects or abnormalities. R6,R7,C8,D7 : Within ±12.5% R6,R7,C8,D7 : 0.2max. More than 6Ω · F No defects or abnormalities.	4 Room Temp 2 to 3 • Initial measurement Perform a heat treatment at 150+0/-10°C for one hour and then let sit for 24±2 hours at room temperature. Perform the initial measurement. • GRM188B30J106M Measurement after test: Perform a heat treatment and then let sit for 24±2 hours at room temperature. Solder the capacitor on the test jig (glass epoxy board) shown in Fig.3 using an eutectic solder. Apply the rated voltage at 40±2°C and 90 to 95% humidity for 500±12 hours. The charge/discharge current is less than 50mA. • Initial measurement Perform a heat treatment at 150+0/-10°C for one hour and then let sit for 24±2 hours at room temperature. Perform the initial measurement. • Neasurement at 150+0/-10°C for one hour and then let sit for 24±2 hours at room temperature. Perform the initial measurement. • Neasurement after test Perform a heat treatment and then let sit for 24±2 hours at room temperature. Solder the capacitor on the test jig (glass epoxy board) shown in Fig.3 using an eutectic solder. Apply 100% of the rated voltage for 1000±12 hours at the maximum operating temperature ±3°C. The charge/ discharge current is less than 50mA • Initial measurement
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SPECIFICATIONS AND TEST METHODS



These Part Numbers are designed for use in the circuits where continuous applied voltage to the capacitor is derated than rated voltage, and guarantee Durability Test with 100% × rated voltage as testing voltage at the maximum operating temperature. The voltage and temperature derating conditions on the left are recommended for use to ensure the same reliability level as normal specification.

Useful Lifetime for mobile application specific MLCC



These MLCC products are designed for use in devices with a typical lifetime of less than 5 years.

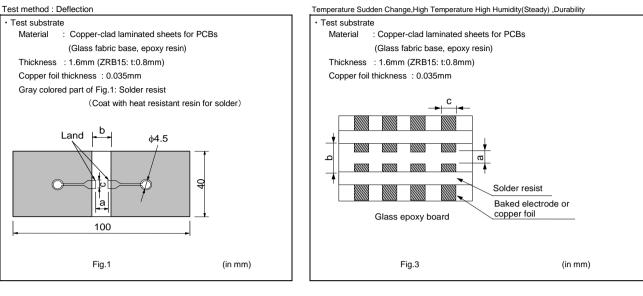
(Examples: Cellular phone, Smartphone, Tablet PC, Digital camera, Watch, Electronics dictionary, Small-scale server, IPC-9592B class1 equipment, etc.) These MLCC products are designed so that the useful lifetime can be extended longer than 5 years under the following conditions:

[80% of the rated voltage or less, Maximum operating temperature -20 degree C or less] Extended useful lifetime, under specific operating conditions, can be estimated from the chart on the left.

%The useful lifetime is the time when cumulative failure rate becomes 1%. *Please note that the useful lifetime data is for reference only and not guaranteed.

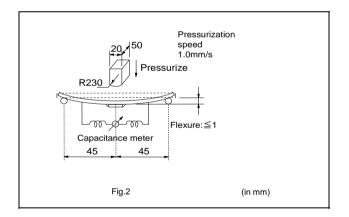
SPECIFICATIONS AND TEST METHODS

Adhesive Strength of Termination, Vibration Resistance, Resistance to Soldering Heat (Reflow method)



Turne		Dimension (mm)	
Туре	а	b	С
ZRB15	0.4	1.5	0.5
ZRB18	1.0	3.0	1.2

Turno		Dimension (mm)	
Туре	а	b	С
ZRB15	0.4	1.5	0.5
ZRB18	1.0	3.0	1.2





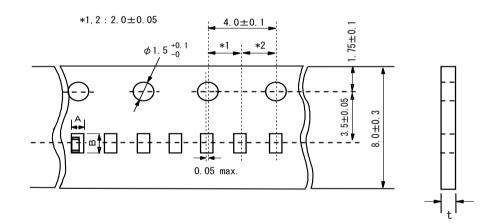
Package ZRB Type

1.Tape Carrier Packaging(Packaging Code:D/L/J/K) 1.1 Minimum Quantity(pcs./reel)

		φ180m	nm reel	φ330m	nm reel
Тур	е	Paper Tape	Plastic Tape	Paper Tape	Plastic Tape
		Code:D	Code:L	Code:J	Code:K
ZRB15	X/7	8000		30000	
ZRB18	Α		3000		8000
ZKDIO	6		4000		10000

1.2 Dimensions of Tape (1)ZRB15

(in:mm)



Туре		Prod	uct Dimensio	ns	A *3	B *3	t *3
туре		L	W	Т	A 3	5	1.5
		1.0±0.15	0.5±0.15	0.65±0.15			
ZRB15	Х	1.0±0.2		0.05±0.15	0.9	1 0	0.95
ZKDIS		1.0±0.22	0.5±0.2	0.65±0.2	0.8	1.3	0.95
	7	1.0+0.22/-0.2		0.7±0.15			

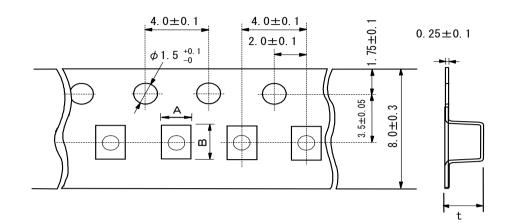
*3 Nominal value

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Package ZRB Type

(2)ZRB18

(in:mm)

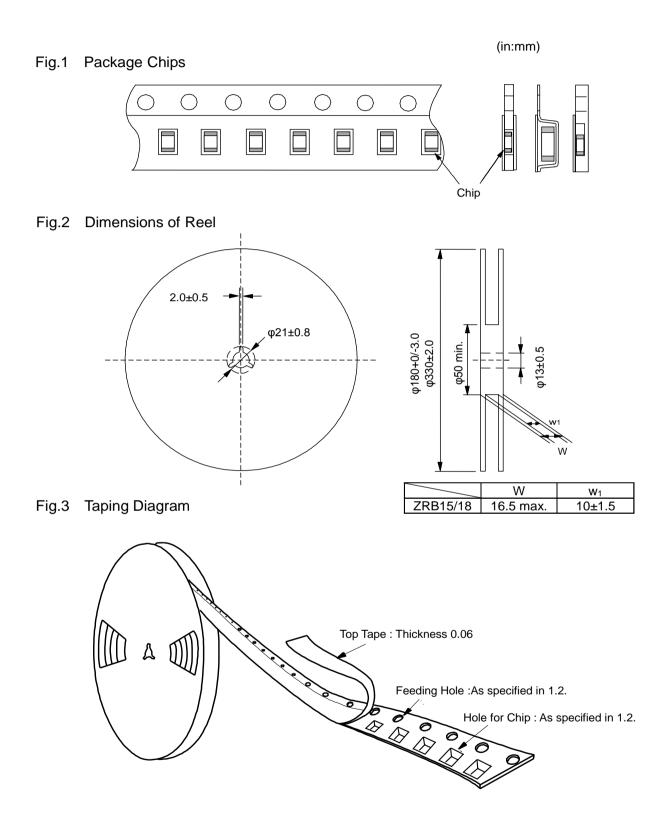


Turne		Pro	oduct Dimensio	ons	A *1	B *1	+
Туре	;	L	W	Т		DI	l
ZRB18	6	1.6±0.22	0.8±0.2	0.6±0.2	1 1	2.0	1.7 max.
	А	1.6±0.2	0.0±0.2	1.0±0.2	1.1	2.0	1.7 max.
					*4 Manalina Junalina		

*1 Nominal value

muRata Package

ZRB Type

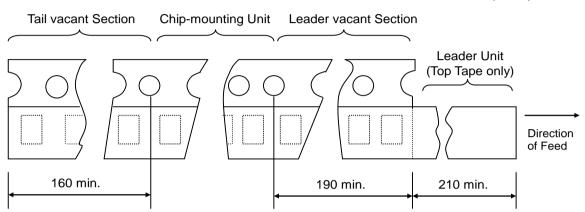




Package ZRBType

- 1.3 Tapes for capacitors are wound clockwise shown in Fig.3.
 - (The sprocket holes are to the right as the tape is pulled toward the user.)
- 1.4 Part of the leader and part of the vacant section are attached as follows.





- 1.5 Accumulate pitch : 10 of sprocket holes pitch = 40 ± 0.3 mm
- 1.6 Chip in the tape is enclosed by top tape and bottom tape as shown in Fig.1.
- 1.7 The top tape and base tape are not attached at the end of the tape for a minimum of 5 pitches.
- 1.8 There are no jointing for top tape and bottom tape.
- 1.9 There are no fuzz in the cavity.
- 1.10 Break down force of top tape : 5N min. Break down force of bottom tape : 5N min. (Only a bottom tape existence)
- 1.11 Reel is made by resin and appeaser and dimension is shown in Fig 2. There are possibly to change the material and dimension due to some impairment.
- 1.12 Peeling off force : 0.1 to 0.6N in the direction as shown below.

•		165~180°	Top tape
	\geq		

1.13 Label that show the customer parts number, our parts number, our company name, inspection number and quantity, will be put in outside of reel.

Limitation of Applications

Please contact us before using our products for the applications listed below which require especially high reliability for the prevention of defects which might directly cause damage to the third party's life, body or property.

①Aircraft equipment
 ②Aerospace equipment
 ③Undersea equipment
 ④Power plant control equipment
 ⑤Medical equipment
 ⑥Transportation equipment(vehicles,trains,ships,etc.)
 ⑦Traffic signal equipment
 ⑧Disaster prevention / crime prevention equipment
 ⑨Data-processing equipment
 ⑩Application of similar complexity and/or reliability requirements to the applications listed in the above.

Storage and Operation condition

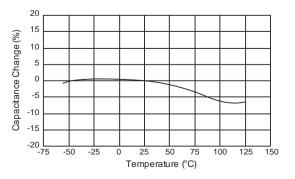
- 1. The performance of chip MLCC on Interposer (ZR series) may be affected by the storage conditions.
- 1-1. Store the capacitors in the following conditions: Room Temperature of +5°C to +40°C and a Relative Humidity of 20% to 70%.
 - (1) Sunlight, dust, rapid temperature changes, corrosive gas atmosphere or high temperature and humidity conditions during storage may affect solderability and packaging performance.
 Therefore, please maintain the storage temperature and humidity. Use the product within six months after receipt, as prolonged storage may cause oxidation of the terminations (outer electrodes).
 - (2) Please confirm solderability before using after six months.
 Store the capacitors without opening the original bag.
 Even if the storage period is short, do not exceed the specified atmospheric conditions.
- 1-2. Corrosive gas can react with the termination (external) electrodes or lead wires of capacitors, and result in poor solderability. Do not store the capacitors in an atmosphere consisting of corrosive gas (e.g.,hydrogen sulfide, sulfur dioxide, chlorine, ammonia gas etc.).
- 1-3. Due to moisture condensation caused by rapid humidity changes, or the photochemical change caused by direct sunlight on the terminal electrodes and/or the resin/epoxy coatings, the solderability and electrical performance may deteriorate. Do not store capacitors under direct sunlight or in high huimidity conditions

Rating

1.Temperature Dependent Characteristics

- 1. The electrical characteristics of the capacitor can change with temperature.
- 1-1. For capacitors having larger temperature dependency, the capacitance may change with temperature changes. The following actions are recommended in order to ensure suitable capacitance values.
 - (1) Select a suitable capacitance for the operating temperature range.
 - (2) The capacitance may change within the rated temperature. When you use a high dielectric constant type capacitor in a circuit that needs a tight (narrow) capacitance tolerance (e.g., a time-constant circuit), please carefully consider the temperature characteristics, and carefully confirm the various characteristics in actual use conditions and the actual system.

[Example of Temperature Caracteristics X7R(R7)] Sample: 0.1µF, Rated Voltage 50VDC





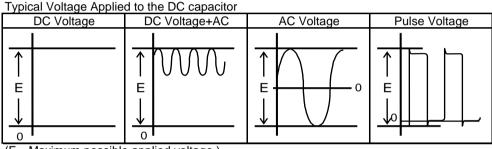


2.Measurement of Capacitance

- 1. Measure capacitance with the voltage and frequency specified in the product specifications.
- 1-1. The output voltage of the measuring equipment may decrease occasionally when capacitance is high. Please confirm whether a prescribed measured voltage is impressed to the capacitor.
- 1-2. The capacitance values of high dielectric constant type capacitors change depending on the AC voltage applied. Please consider the AC voltage characteristics when selecting a capacitor to be used in a AC circuit.

3.Applied Voltage

- 1. Do not apply a voltage to the capacitor that exceeds the rated voltage as called out in the specifications.
- 1-1. Applied voltage between the terminals of a capacitor shall be less than or equal to the rated voltage.
- (1) When AC voltage is superimposed on DC voltage, the zero-to-peak voltage shall not exceed the rated DC voltage. When AC voltage or pulse voltage is applied, the peak-to-peak voltage shall not exceed the rated DC voltage.
- (2) Abnormal voltages (surge voltage, static electricity, pulse voltage, etc.) shall not exceed the rated DC voltage.
- (2) Abnormal voltages (surge voltage, static electricity, puise voltage, etc.) shall not exceed the fateu DC voltage



(E : Maximum possible applied voltage.)

1-2. Influence of over voltage

Over voltage that is applied to the capacitor may result in an electrical short circuit caused by the breakdown of the internal dielectric layers .

The time duration until breakdown depends on the applied voltage and the ambient temperature.

4.Type of Applied Voltage and Self-heating Temperature

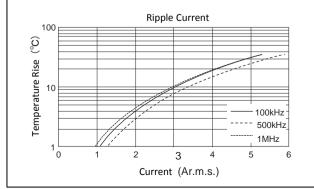
1.Confirm the operating conditions to make sure that no large current is flowing into the capacitor due to the continuous application of an AC voltage or pulse voltage.

When a DC rated voltage product is used in an AC voltage circuit or a pulse voltage circuit, the AC current or pulse current will flow into the capacitor; therefore check the self-heating condition.

Please confirm the surface temperature of the capacitor so that the temperature remains within the upper limits of the operating temperature, including the rise in temperature due to self-heating. When the capacitor is used with a high-frequency voltage or pulse voltage, heat may be generated by dielectric loss.

<Applicable to Rated Voltage of less than 100VDC>

 1-1. The load should be contained to the level such that when measuring at atmospheric temperature of 25°C, the product's self-heating remains below 20°C and the surface temperature of the capacitor in the actual circuit remains within the maximum operating temperature. $\label{eq:constraint} \begin{array}{l} [Example of Temperature Rise (Heat Generation) in Chip \\ Monolithic Ceramic Capacitors in Contrast to Ripple Current] \\ Sample: R(R1) characteristics 10 \mu F, Rated voltage: DC10V \end{array}$



5. DC Voltage and AC Voltage Characteristic

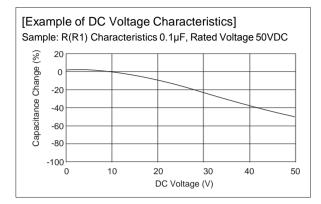
- The capacitance value of a high dielectric constant type capacitor changes depending on the DC voltage applied. Please consider the DC voltage characteristics when a capacitor is selected for use in a DC circuit.
- 1-1. The capacitance of ceramic capacitors may change sharply depending on the applied voltage. (See figure) Please confirm the following in order to secure the capacitance.
- (1) Determine whether the capacitance change caused by the applied voltage is within the allowed range .
- (2) In the DC voltage characteristics, the rate of capacitance change becomes larger as voltage increases, even if the applied voltage is below the rated voltage. When a high dielectric constant type capacitor is used in a circuit that requires a tight (narrow) capacitance tolerance (e.g., a time constant circuit), please carefully consider the voltage characteristics, and confirm the various characteristics in the actual operating conditions of the system.
- The capacitance values of high dielectric constant type capacitors changes depending on the AC voltage applied.
 Please consider the AC voltage characteristics when selecting a capacitor to be used in a AC circuit.

6. Capacitance Aging

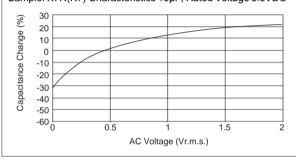
 The high dielectric constant type capacitors have an Aging characteristic in which the capacitance value decreases with the passage of time. When you use a high dielectric constant type capacitors in a circuit that needs a tight (narrow) capacitance tolerance (e.g., a time-constant circuit), please carefully consider the characteristics of these capacitors, such as their aging, voltage, and temperature characteristics. In addition, check capacitors using your actual appliances at the intended environment and operating conditions.

7.Vibration and Shock

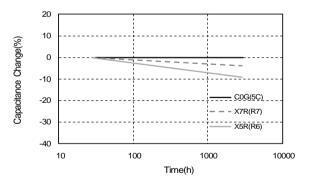
- 1. Please confirm the kind of vibration and/or shock, its condition, and any generation of resonance. Please mount the capacitor so as not to generate resonance, and do not allow any impact on the terminals.
- Mechanical shock due to being dropped may cause damage or a crack in the dielectric material of the capacitor. Do not use a dropped capacitor because the quality and reliability may be deteriorated.
- 3. When printed circuit boards are piled up or handled, the corner of another printed circuit board should not be allowed to hit the capacitor in order to avoid a crack or other damage to the capacitor.

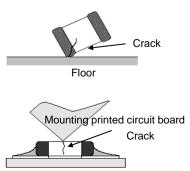






[Example of Change Over Time (Aging characteristics)]

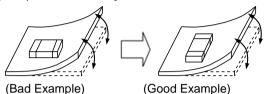




■Soldering and Mounting

1.Mounting Position

- 1. Confirm the best mounting position and direction that minimizes the stress imposed on the capacitor during flexing or bending the printed circuit board.
- 1-1. Choose a mounting position that minimizes the stress imposed on the chip during flexing or bending of the board. [Component Direction]



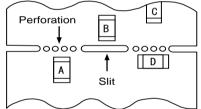
Locate chip horizontal to the direction in which stress acts.

[Chip Mounting Close to Board Separation Point]

It is effective to implement the following measures, to reduce stress in separating the board.

It is best to implement all of the following three measures; however, implement as many measures as possible to reduce stress.

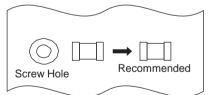
Contents of Measures	Stress Level
(1) Turn the mounting direction of the component parallel to the board separation surface.	A > D *1
(2) Add slits in the board separation part.	A > B
(3) Keep the mounting position of the component away from the board separation surface.	A > C



*1 A > D is valid when stress is added vertically to the perforation as with Hand Separation. If a Cutting Disc is used, stress will be diagonal to the PCB, therefore A > D is invalid.

[Mounting Capacitors Near Screw Holes]

When a capacitor is mounted near a screw hole, it may be affected by the board deflection that occurs during the tightening of the screw. Mount the capacitor in a position as far away from the screw holes as possible.



2.Information before Mounting

- 1. Do not re-use capacitors that were removed from the equipment.
- 2. Confirm capacitance characteristics under actual applied voltage.
- 3. Confirm the mechanical stress under actual process and equipment use.
- 4. Confirm the rated capacitance, rated voltage and other electrical characteristics before assembly.
- 5. Prior to use, confirm the solderability of capacitors that were in long-term storage.
- 6. Prior to measuring capacitance, carry out a heat treatment for capacitors that were in long-term storage.
- 7. The use of Sn-Zn based solder will deteriorate the reliability of the MLCC. Please contact our sales representative or product engineers on the use of Sn-Zn based solder in advance.

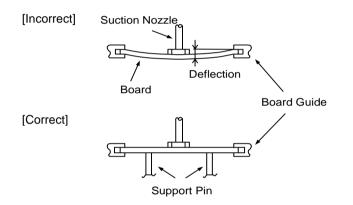
JEMCGC-02188C

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3.Maintenance of the Mounting (pick and place) Machine

- 1. To adjust the inspection tolerance for automated appearance sorting machine of mounting position, because ZR□ series are easier to shift the mounting position than standard MLCC.
- 2. To check the overturn and reverse of ZR I series.
- 3. To control mounting speed carefully, because ZR I series is heavier than standard MLCC.
- 4. Make sure that the following excessive forces are not applied to the capacitors.
- 4-1. In mounting the capacitors on the printed circuit board, any bending force against them shall be kept to a minimum to prevent them from any damage or cracking. Please take into account the following precautions and recommendations for use in your process.
 - (1) Adjust the lowest position of the pickup nozzle so as not to bend the printed circuit board.
 - (2) Adjust the nozzle pressure within a static load of 1N to 3N during mounting.

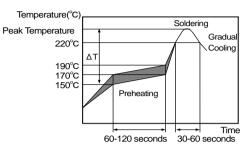


2.Dirt particles and dust accumulated between the suction nozzle and the cylinder inner wall prevent the nozzle from moving smoothly. This imposes greater force upon the chip during mounting, causing cracked chips. Also, the locating claw, when worn out, imposes uneven forces on the chip when positioning, causing cracked chips. The suction nozzle and the locating claw must be maintained, checked and replaced periodically.

4-1.Reflow Soldering

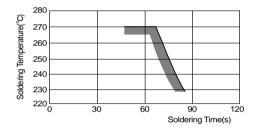
- 1. When sudden heat is applied to the components, the mechanical strength of the components will decrease because a sudden temperature change causes deformation inside the components. In order to prevent mechanical damage to the components, preheating is required for both the components and the PCB. Preheating conditions are shown in table 1. It is required to keep the temperature differential between the solder and the components surface (Δ T) as small as possible.
- 2. Solderability of tin plating termination chips might be deteriorated when a low temperature soldering profile where the peak solder temperature is below the melting point of tin is used. Please confirm the solderability of tin plated termination chips before use.
- 3. When components are immersed in solvent after mounting, be sure to maintain the temperature difference (ΔT) between the component and the solvent within the range shown in the table 1.

[Standard Conditions for Reflow Soldering]



[Allowable Reflow Soldering Temperature and Time]

	Table 1			
	Series Chip Dimension(L/W) Code		Temperature Differential	
_	ZRB	15/18	ΔT≦190°C	



In the case of repeated soldering, the accumulated soldering time must be within the range shown above.

_		.	
Recom	mended	Conditio	ns

	Lead Free Solder	
Peak Temperature	240 to 260°C	
Atmosphere	Air or N ₂	

Lead Free Solder: Sn-3.0Ag-0.5Cu

4-2.Flow Soldering

1. ZR series is not apply flow soldering.

4-3.Correction of Soldered Portion

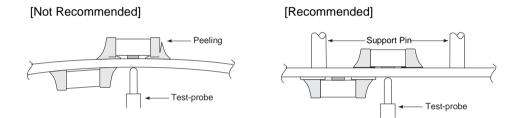
Do not correct with a soldering iron for $ZR\square$ series. Correction with a soldering iron for $ZR\square$ series may cause loss suppress acoustic noise, because the solder amount become excessive.

5.Washing

Excessive ultrasonic oscillation during cleaning can cause the PCBs to resonate, resulting in cracked chips or broken solder joints. Take note not to vibrate PCBs.

6.Electrical Test on Printed Circuit Board

- 1. Confirm position of the support pin or specific jig, when inspecting the electrical performance of a capacitor after mounting on the printed circuit board.
 - 1-1. Avoid bending the printed circuit board by the pressure of a test-probe, etc. The thrusting force of the test probe can flex the PCB, resulting in cracked chips or open solder joints. Provide support pins on the back side of the PCB to prevent warping or flexing. Install support pins as close to the test-probe as possible.
 - 1-2. Avoid vibration of the board by shock when a test -probe contacts a printed circuit board.



7.Printed Circuit Board Cropping

- 1. After mounting a capacitor on a printed circuit board, do not apply any stress to the capacitor that caused bending or twisting the board.
 - 1-1. In cropping the board, the stress as shown may cause the capacitor to crack. Cracked capacitors may cause deterioration of the insulation resistance, and result in a short. Avoid this type of stress to a capacitor.





- 2. Check the cropping method for the printed circuit board in advance.
 - 2-1. Printed circuit board cropping shall be carried out by using a jig or an apparatus (Disc separator, router type separator, etc.) to prevent the mechanical stress that can occur to the board.

Board Separation Method	Hand Separation Nipper Separation	(1) Board Separation Jig	Board Separation Apparatus	
			Disc Separator	3) Router Type Separator
Level of stress on board	High	Medium	Medium	Low
Recommended	×	Δ^*	Δ^*	\bigcirc
	Hand and nipper separation apply a high level of stress. Use another method.	 Board handling Board bending direction Layout of capacitors 	 Board handling Layout of slits Design of V groove Arrangement of blades Controlling blade life 	Board handling

* When a board separation jig or disc separator is used, if the following precautions are not observed, a large board deflection stress will occur and the capacitors may crack. Use router type separator if at all possible.

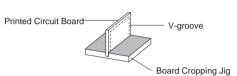
(1) Example of a suitable jig

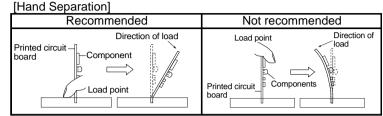
[In the case of Single-side Mounting]

An outline of the board separation jig is shown as follows.

Recommended example: Stress on the component mounting position can be minimized by holding the portion close to the jig, and bend in the direction towards the side where the capacitors are mounted. Not recommended example: The risk of cracks occurring in the capacitors increases due to large stress being applied to the component mounting position, if the portion away from the jig is held and bent in the direction opposite the side where the capacitors are mounted.

[Outline of jig]





[In the case of Double-sided Mounting]

Since components are mounted on both sides of the board, the risk of cracks occurring can not be avoided with the above method. Therefore, implement the following measures to prevent stress from being applied to the components. (Measures)

(1) Consider introducing a router type separator.

If it is difficult to introduce a router type separator, implement the following measures. (Refer to item 1. Mounting Position)

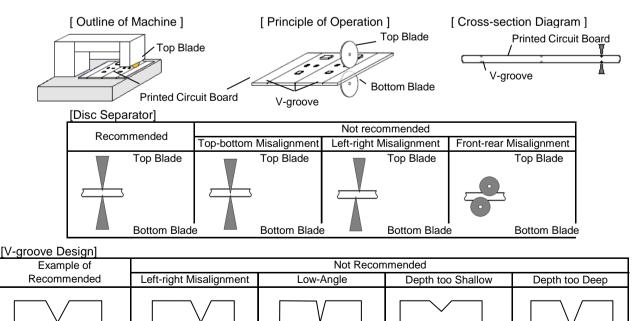
- (2) Mount the components parallel to the board separation surface.
- (3) When mounting components near the board separation point, add slits in the separation position near the component.
- (4) Keep the mounting position of the components away from the board separation point.

(2) Example of a Disc Separator

An outline of a disc separator is shown as follows. As shown in the Principle of Operation, the top blade and bottom blade are aligned with the V-grooves on the printed circuit board to separate the board. In the following case, board deflection stress will be applied and cause cracks in the capacitors.

- (1) When the adjustment of the top and bottom blades are misaligned, such as deviating in the top-bottom, left-right or front-rear directions
- (2) The angle of the V groove is too low, depth of the V groove is too shallow, or the V groove is misaligned top-bottom

IF V groove is too deep, it is possible to brake when you handle and carry it. Carefully design depth of the V groove with consideration about strength of material of the printed circuit board.



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(3) Example of Router Type Separator

The router type separator performs cutting by a router rotating at a high speed. Since the board does not bend in the cutting process, stress on the board can be suppressed during board separation. When attaching or removing boards to/from the router type separator, carefully handle the boards to prevent bending.

8. Assembly

1. Handling

If a board mounted with capacitors is held with one hand, the board may bend.

Firmly hold the edges of the board with both hands when handling.

If a board mounted with capacitors is dropped, cracks may occur in the capacitors.

Do not use dropped boards, as there is a possibility that the quality of the capacitors may be impaired.

2. Attachment of Other Components

2-1. Mounting of Other Components

Pay attention to the following items, when mounting other components on the back side of the board after capacitors have been mounted on the opposite side.

When the bottom dead point of the suction nozzle is set too low, board deflection stress may be applied to the capacitors on the back side (bottom side), and cracks may occur in the capacitors.

· After the board is straightened, set the bottom dead point of the nozzle on the upper surface of the board.

· Periodically check and adjust the bottom dead point.



2-2. Inserting Components with Leads into Boards

When inserting components (transformers, IC, etc.) into boards, bending the board may cause cracks in the capacitors or cracks in the solder. Pay attention to the following.

- · Increase the size of the holes to insert the leads, to reduce the stress on the board during insertion.
- · Fix the board with support pins or a dedicated jig before insertion.
- Support below the board so that the board does not bend. When using multiple support pins on the board, periodically confirm that there is no difference in the height of each support pin.

Component with Leads



2-3. Attaching/Removing Sockets

When the board itself is a connector, the board may bend when a socket is attached or removed. Plan the work so that the board does not bend when a socket is attached or removed.



2-4. Tightening Screws

The board may be bent, when tightening screws, etc. during the attachment of the board to a shield or chassis. Pay attention to the following items before performing the work.

- · Plan the work to prevent the board from bending.
- · Use a torque screwdriver, to prevent over-tightening of the screws.
- The board may bend after mounting by reflow soldering, etc. Please note, as stress may be applied to the chips by forcibly flattening the board when tightening the screws.



Others

1. Under Operation of Equipment

- 1-1. Do not touch a capacitor directly with bare hands during operation in order to avoid the danger of an electric shock.
- 1-2. Do not allow the terminals of a capacitor to come in contact with any conductive objects (short-circuit). Do not expose a capacitor to a conductive liquid, inducing any acid or alkali solutions.
- 1-3. Confirm the environment in which the equipment will operate is under the specified conditions.
 - Do not use the equipment under the following environments.
 - (1) Being spattered with water or oil.
 - (2) Being exposed to direct sunlight.
 - (3) Being exposed to ozone, ultraviolet rays, or radiation.
 - (4) Being exposed to toxic gas (e.g., hydrogen sulfide, sulfur dioxide, chlorine, ammonia gas etc.)
 - (5) Any vibrations or mechanical shocks exceeding the specified limits.
 - (6) Moisture condensing environments.
- 1-4. Use damp proof countermeasures if using under any conditions that can cause condensation.

2. Others

- 2-1. In an Emergency
- (1) If the equipment should generate smoke, fire, or smell, immediately turn off or unplug the equipment. If the equipment is not turned off or unplugged, the hazards may be worsened by supplying continuous power.
- (2) In this type of situation, do not allow face and hands to come in contact with the capacitor or burns may be caused by the capacitor's high temperature.
- 2-2. Disposal of waste

When capacitors are disposed of, they must be burned or buried by an industrial waste vendor with the appropriate licenses.

- 2-3. Circuit Design
- (1) Addition of Fail Safe Function

Capacitors that are cracked by dropping or bending of the board may cause deterioration of the insulation resistance, and result in a short. If the circuit being used may cause an electrical shock, smoke or fire when a capacitor is shorted, be sure to install fail-safe functions, such as a fuse, to prevent secondary accidents.

(2) This series are not safety standard certified products.

2-4. Remarks

Failure to follow the cautions may result, worst case, in a short circuit and smoking when the product is used. The above notices are for standard applications and conditions. Contact us when the products are used in special mounting conditions.

Select optimum conditions for operation as they determine the reliability of the product after assembly. The data herein are given in typical values, not guaranteed ratings.

muRata Notice

Rating

1.Operating Temperature

- 1. The operating temperature limit depends on the capacitor.
- 1-1. Do not apply temperatures exceeding the maximum operating temperature.
 It is necessary to select a capacitor with a suitable rated temperature that will cover the operating temperature range.
 It is also necessary to consider the temperature distribution in equipment and the seasonal temperature variable factor.
- 1-2. Consider the self-heating factor of the capacitor The surface temperature of the capacitor shall not exceed the maximum operating temperature including self-heating.

2.Atmosphere Surroundings (gaseous and liquid)

- 1. Restriction on the operating environment of capacitors.
- 1-1. Capacitors, when used in the above, unsuitable, operating environments may deteriorate due to the corrosion of the terminations and the penetration of moisture into the capacitor.
- 1-2. The same phenomenon as the above may occur when the electrodes or terminals of the capacitor are subject to moisture condensation.
- 1-3. The deterioration of characteristics and insulation resistance due to the oxidization or corrosion of terminal electrodes may result in breakdown when the capacitor is exposed to corrosive or volatile gases or solvents for long periods of time.

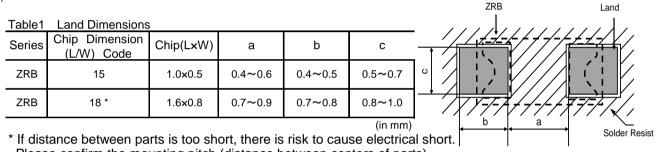
3.Piezo-electric Phenomenon

1. When using high dielectric constant type capacitors in AC or pulse circuits, the capacitor itself vibrates at specific frequencies and noise may be generated. Moreover, when the mechanical vibration or shock is added to capacitor, noise may occur.

■Soldering and Mounting

1.PCB Design

- 1. Notice for Pattern Forms
- 1-1. There is a possibility of chip cracking caused by PCB expansion/contraction with heat, because stress on a chip is different depending on PCB material and structure. When the thermal expansion coefficient greatly differs between the board used for mounting and the chip, it will cause cracking of the chip due to the thermal expansion and contraction. When capacitors are mounted on a fluorine resin printed circuit board or on a single-layered glass epoxy board, it may also cause cracking of the chip for the same reason.
- 2. Land Dimensions
- 2-1.Please refer to the land dimensions in Table 1 for ZRB series.
 - (1)Recommended Land Dimensions



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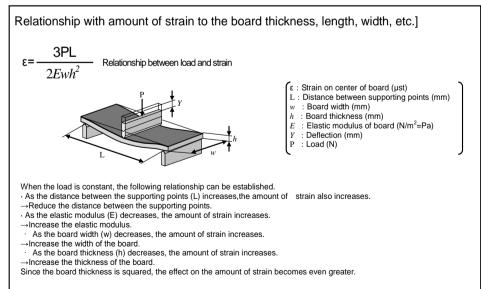
Notice

Please confirm the mounting pitch (distance between centers of parts) has 1.275mm or more. (ZRB18 only)

Please confirm the suitable mounting condition by evaluating of the actual SET / PCB.

3. Board Design

When designing the board, keep in mind that the amount of strain which occurs will increase depending on the size and material of the board.



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2.Reflow soldering

The halogen system substance and organic acid are included in solder paste, and a chip corrodes by this kind of solder paste.

Do not use strong acid flux.

Do not use water-soluble flux.*

(*Water-soluble flux can be defined as non-rosin type flux including wash-type flux and non-wash-type flux.)

3.Washing

- 1. Please evaluate the capacitor using actual cleaning equipment and conditions to confirm the quality, and select the solvent for cleaning.
- 2. Unsuitable cleaning solvent may leave residual flux or other foreign substances, causing deterioration of electrical characteristics and the reliability of the capacitors.
- 3. Select the proper cleaning conditions.
- 3-1. Improper cleaning conditions (excessive or insufficient) may result in the deterioration of the performance of the capacitors.

4.Coating

1. Loss suppress acoustic noise may be caused in ZR□ series due to the resin during curing process. Please contact our sales representative or product engineers on the apply to resin during curing process.

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Others

1.Transportation

- 1. The performance of a capacitor may be affected by the conditions during transportation.
- 1-1. The capacitors shall be protected against excessive temperature, humidity and mechanical force during transportation.
 - (1) Climatic condition
 - low air temperature : -40°C
 - change of temperature air/air : -25°C/+25°C
 - low air pressure : 30 kPa
 - · change of air pressure : 6 kPa/min.

(2) Mechanical condition

Transportation shall be done in such a way that the boxes are not deformed and forces are not directly passed on to the inner packaging.

- 1-2. Do not apply excessive vibration, shock, or pressure to the capacitor.
 - (1) When excessive mechanical shock or pressure is applied to a capacitor, chipping or cracking may occur in the ceramic body of the capacitor.
 - (2) When the sharp edge of an air driver, a soldering iron, tweezers, a chassis, etc. impacts strongly on the surface of the capacitor, the capacitor may crack and short-circuit.
- 1-3. Do not use a capacitor to which excessive shock was applied by dropping etc. A capacitor dropped accidentally during processing may be damaged.

2.Characteristics Evaluation in the Actual System

- 1. Evaluate the capacitor in the actual system, to confirm that there is no problem with the performance and specification values in a finished product before using.
- 2. Since a voltage dependency and temperature dependency exists in the capacitance of high dielectric type ceramic capacitors, the capacitance may change depending on the operating conditions in the actual system. Therefore, be sure to evaluate the various characteristics, such as the leakage current and noise absorptivity, which will affect the capacitance value of the capacitor.
- 3. In addition, voltages exceeding the predetermined surge may be applied to the capacitor by the inductance in the actual system. Evaluate the surge resistance in the actual system as required.

- 1.Please make sure that your product has been evaluated in view of your specifications with our product being mounted to your product.
- 2. Your are requested not to use our product deviating from this product specification.
- 3.We consider it not appropriate to include any terms and conditions with regard to the business transaction in the product specifications, drawings or other technical documents. Therefore, if your technical documents as above include such terms and conditions such as warranty clause, product liability clause, or intellectual property infringement liability clause, they will be deemed to be invalid.

单击下面可查看定价,库存,交付和生命周期等信息

>>Murata(村田)